# YIBO LIN

Assistant Professor & Center for Energy-efficient Computing and Applications & School of EECS Science Building #5, 5 Yiheyuan Road, Beijing, China, 100871 & Peking University yibolin@pku.edu.cn & www.yibolin.com

#### RESEARCH INTERESTS

Modeling and optimization in VLSI CAD, machine learning applications, GPU acceleration, and hardware security

#### **EDUCATION**

#### University of Texas at Austin, TX, USA

Aug. 2013 - May 2018

Ph.D. student, Department of Electrical and Computer Engineering

Advisor: David Z. Pan

Dissertation: "Bridging Design and Manufacturing Gap through Machine Learning and Machine-Generated Lay-

out"

(GPA 3.96/4.0)

#### Shanghai Jiao Tong University, Shanghai, P.R.China

Sep. 2009 - Jun. 2013

B.S., Department of Microelectronics

(GPA 91.17/100)

(Rank top 1/60)

#### **EXPERIENCE**

Peking University, Beijing, China	$\it Jul.2019-present$
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Assistant Professor

Center for Energy-efficient Computing and Applications (CECA)

School of EECS

University of Texas at Austin, Texas, U.S.

Jun. 2018 – Jun. 2019

Postdoc

ECE Department

Toshiba Memory Corporation, Yokohama, Japan May 2017 - Aug. 2017

Internship

Memory lithography group

IMEC, Leuven, Belgium

Sep. 2016 – Nov. 2016

Internship

Design technology co-optimization for emerging lithography options

Chinese University of Hong Kong, China

Jun. 2016 – Aug. 2016

Summer Intern

Quantum computing

Cadence Design System, TX, USA

May 2015 - Aug. 2015

Summer Intern

Routability driven detailed placement

Oracle Inc., TX, USA May 2014 - Aug. 2014

Summer Intern

Incremental timing driven detailed placement

#### TEACHING EXPERIENCE

Guest Lecture	EE382M: VLSI CAD & Optimizations	Fall 2018
Guest Lecture	EE382M: VLSI Physical Design Automation	Fall 2017
Graduate Teaching Assistant	EE382M: VLSI I	Fall 2014

#### **PUBLICATIONS**

#### **Book Chapters**

[B1] Yibo Lin and David Z. Pan, "Machine Learning in Physical Verification, Mask Synthesis, and Physical Design", Machine Learning in VLSI Computer-Aided Design, Springer, 2018, edited by Abe Elfedel, Duane Boning and Xin Li. (Invited Book Chapter)

#### Journal Papers

- [J15] Jing Chen, Yibo Lin, Yufeng Guo, Maolin Zhang, Mohamed Baker Alawieh and David Z. Pan, "Lithography Hotspot Detection Using a Double Inception Module Architecture", Journal of Micro/Nanolithography, MEMS, and MOEMS (JM3), 2019.
- [J14] Ying Chen, Yibo Lin, Tianyang Gai, Yajuan Su, Yayi Wei and David Z. Pan, "Semi-Supervised Hotspot Detection with Self-Paced Multi-Task Learning", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), 2019.
- [J13] Yibo Lin, Meng Li, Yuki Watanabe, Taiki Kimura, Tetsuaki Matsunawa, Shigeki Nojima and David Z. Pan, "Data Efficient Lithography Modeling with Transfer Learning and Active Data Selection", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Oct, 2019.
- [J12] Yibo Lin, Bei Yu, Meng Li and David Z. Pan, "Layout Synthesis for Topological Quantum Circuits with 1D and 2D Architectures", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Aug, 2018.
- [J11] Meng Li, Bei Yu, Yibo Lin, Xiaoqing Xu, Wuxi Li and David Z Pan, "A practical split manufacturing framework for trojan prevention via simultaneous wire lifting and cell insertion", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Jul, 2018.
- [J10] Xiaoqing Xu, Yibo Lin, Meng Li, Tetsuaki Matsunawa, Shigeki Nojima, Chikaaki Kodama, Toshiya Kotani and David Z. Pan, "Subresolution Assist Feature Generation With Supervised Data Learning", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Jun, 2018.
- [J9] Yibo Lin, Bei Yu, Xiaoqing Xu, Jhih-Rong Gao, Natarajan Viswanathan, Wen-Hao Liu, Zhuo Li, Charles J Alpert and David Z. Pan, "MrDP: Multiple-row detailed placement of heterogeneous-sized cells for advanced nodes", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Jun, 2018.
- [J8] Wuxi Li, Yibo Lin, Meng Li, Shounak Dhar and David Z. Pan, "UTPlaceF 2.0: A High-Performance Clock-Aware FPGA Placement Engine", ACM Transactions on Design Automation of Electronic Systems (TODAES), Jun, 2018.
- [J7] Yibo Lin, Bei Yu and David Z. Pan, "High performance dummy fill insertion with coupling and uniformity constraints", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Sep, 2017.
- [J6] Yibo Lin, Bei Yu, Biying Xu and David Z. Pan, "Triple patterning aware detailed placement toward zero cross-row middle-of-line conflict", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Jul, 2017.
- [J5] Xiaoqing Xu, Yibo Lin, Meng Li, Jiaojiao Ou, B. Cline and D. Z. Pan, "Redundant local-Loop insertion for unidirectional routing", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), Jul, 2017.
- [J4] Yibo Lin, Bei Yu, Yi Zou, Zhuo Li, Charles J Alpert and David Z. Pan, "Stitch aware detailed placement for multiple e-beam lithography", Integration, the VLSI Journal, Jun, 2017. (Best Paper Award)
- [J3] Yibo Lin, Xiaoqing Xu, Bei Yu, Ross Baldick and David Z. Pan, "Triple/quadruple patterning layout decomposition via linear programming and iterative rounding", Journal of Micro/Nanolithography, MEMS, and MOEMS (JM3), Jun, 2017.
- [J2] Bei Yu, Xiaoqing Xu, Subhendu Roy, Yibo Lin, Jiaojiao Ou and David Z. Pan, "Design for manufacturability and reliability in extreme-scaling VLSI", Science China Information Sciences, 2016. (Invited paper)
- [J1] Bei Yu, Xiaoqing Xu, Jhih-Rong Gao, **Yibo Lin**, Zhuo Li, Charles Alpert and David Z. Pan, "Methodology for standard cell compliance and detailed placement for triple patterning lithography", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems (TCAD), May, 2015.

#### Conference Papers

- [C34] Mingjie Liu, Wuxi Li, Keren Zhu, Biying Xu, Yibo Lin, Linxiao Shen, Xiyuan Tang, Nan Sun and David Z. Pan, "S3DET: Detecting System Symmetry Constraints for Analog Circuits with Graph Similarity", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), 2020.
- [C33] Mohamed Baker Alawieh, Wuxi Li, Yibo Lin, Love Singhal, Mahesh Iyer and David Z. Pan, "High-Definition Routing Congestion Prediction for Large-Scale FPGAs", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), 2020.
- [C32] Wuxi Li, Yibo Lin and David Z. Pan, "elfPlace: Electrostatics-based Placement for Large-Scale Heterogeneous FPGAs", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Westminster, CO, Nov 4-7, 2019. (accepted)
- [C31] Keren Zhu, Mingjie Liu, Yibo Lin, Biying Xu, Shaolan Li, Xiyuan Tang, Nan Sun and David Z. Pan, "GeniusRoute: A New Analog Routing Paradigm Using Generative Neural Network Guidance", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Westminster, CO, Nov 4-7, 2019. (accepted)
- [C30] Chengyue Gong, Zixuan Jiang, Dilin Wang, Yibo Lin, Qiang Liu and David Z. Pan, "Mixed Precision Neural Architecture Search for Energy Efficient Deep Learning", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Westminster, CO, Nov 4-7, 2019. (accepted)
- [C29] Wei Li, Yuzhe Ma, Qi Sun, Yibo Lin, Iris Hui-Ru Jiang, Bei Yu and David Z Pan, "OpenMPL: An Open Source Layout Decomposer", International Conference on ASIC (ASICON), Chongqing, China, Oct, 2019. (Invited paper)
- [C28] Yibo Lin, Shounak Dhar, Wuxi Li, Haoxing Ren, Brucek Khailany and David Z. Pan, "DREAMPlace: Deep Learning Toolkit-Enabled GPU Acceleration for Modern VLSI Placement", ACM/IEEE Design Automation Conference (DAC), Las Vegas, NV, Jun 2-6, 2019. (Best Paper Award)
- [C27] Wei Ye, Mohamed Baker Alawieh, Yibo Lin and David Z. Pan, "LithoGAN: End-to-End Lithography Modeling with Generative Adversarial Networks", ACM/IEEE Design Automation Conference (DAC), Las Vegas, NV, Jun 2-6, 2019. (Best Paper Nomination)
- [C26] Biying Xu, Yibo Lin, Xiyuan Tang, Shaolan Li, Linxiao Shen, Nan Sun and David Z. Pan, "Well-GAN: Generative-Adversarial-Network-Guided Well Generation for Analog/Mixed-Signal Circuit Layout", ACM/IEEE Design Automation Conference (DAC), Las Vegas, NV, Jun 2-6, 2019.
- [C25] Mohamed Baker Alawieh, Yibo Lin, Zaiwei Zhang, Meng Li, Qixing Huang and David Z. Pan, "GAN-SRAF: Sub-Resolution Assist Feature Generation Using Conditional Generative Adversarial Networks", ACM/IEEE Design Automation Conference (DAC), Las Vegas, NV, Jun 2-6, 2019.
- [C24] Yibo Lin, Zhao Song and Lin F. Yang, "Towards a Theoretical Understanding of Hashing-Based Neural Nets", International Conference on Artificial Intelligence and Statistics (AISTATS), Okinawa, Japan, Apr 16-18, 2019.
- [C23] Biying Xu, Shaolan Li, Chak-Wa Pui, Derong Liu, Linxiao Shen, Yibo Lin, Nan Sun and David Z. Pan, "Device Layer-Aware Analytical Placement for Analog Circuits", ACM International Symposium on Physical Design (ISPD), San Francisco, CA, Apr 14-17, 2019. (Best Paper Nomination)
- [C22] Wei Ye, Mohamed Baker Alawieh, Meng Li, Yibo Lin and David Z. Pan, "Litho-GPA: Gaussian Process Assurance for Lithography Hotspot Detection", IEEE/ACM Proceedings Design, Automation and Test in Eurpoe (DATE), Florence, Italy, Mar 25-29, 2019.
- [C21] Ying Chen, Yibo Lin, Tianyang Gai, Yajuan Su, Yayi Wei and David Z. Pan, "Semi-Supervised Hotspot Detection with Self-Paced Multi-Task Learning", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Tokyo, Japan, Jan 21-24, 2019.
- [C20] Wei Ye, Mohamed Baker Alawieh, Yibo Lin and David Z. Pan, "Tackling Signal Electromigration with Learning-Based Detection and Multistage Mitigation", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Tokyo, Japan, Jan 21-24, 2019.
- [C19] Wei Ye, Yibo Lin, Meng Li, Qiang Liu and David Z. Pan, "LithoROC: Lithography Hotspot Detection with Explicit ROC Optimization", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Tokyo, Japan, Jan 21-24, 2019. (Invited paper)
- [C18] Yibo Lin, Mohamed Baker Alawieh, Wei Ye and David Z. Pan, "Machine Learning for Yield Learning and Optimization", IEEE International Test Conference (ITC), Phoenix, Arizona, Oct, 2018. (Invited paper)

- [C17] Jiong Zhang, Yibo Lin, Zhao Song and Inderjit S Dhillon, "Learning Long Term Dependencies via Fourier Recurrent Units", International Conference on Machine Learning (ICML), Stockholm, Sweden, Jun 10-15, 2018.
- [C16] Yibo Lin, Yuki Watanabe, Taiki Kimura, Tetsuaki Matsunawa, Shigeki Nojima, Meng Li and David Z. Pan, "Data Efficient Lithography Modeling with Residual Neural Networks and Transfer Learning", ACM International Symposium on Physical Design (ISPD), Monterey, CA, Mar 25-28, 2018.
- [C15] Meng Li, Bei Yu, Yibo Lin, Xiaoqing Xu, Wuxi Li and David Z. Pan, "A Practical Split Manufacturing Framework for Trojan Prevention via Simultaneous Wire Lifting and Cell Insertion", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Jeju, Korea, Jan 22-25, 2018.
- [C14] Che-Lun Hsu, Shaofeng Guo, Yibo Lin, Xiaoqing Xu, Meng Li, Runsheng Wang, Ru Huang and David Z Pan, "Layout-dependent aging mitigation for critical path timing", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Jeju, Korea, Jan 22-25, 2018.
- [C13] Yibo Lin, Peter Debacker, Darko Trivkovic, Ryoung-han Kim, Praveen Raghavan and David Z. Pan, "Patterning Aware Design Optimization of Selective Etching in N5 and Beyond", IEEE International Conference on Computer Design (ICCD), Boston, MA, Nov 5-8, 2017.
- [C12] Yibo Lin, Xiaoqing Xu, Jiaojiao Ou and David Z Pan, "Machine learning for mask/wafer hotspot detection and mask synthesis", Photomask Technology, Oct 16, 2017. (Invited paper)
- [C11] Wei Ye, Yibo Lin, Xiaoqing Xu, Wuxi Li, Yiwei Fu, Yongsheng Sun, Canhui Zhan and David Z. Pan, "Placement Mitigation Techniques for Power Grid Electromigration", IEEE International Symposium on Low Power Electronics and Design (ISLPED), Taipei, Jul 24-26, 2017.
- [C10] Xiaoqing Xu, Yibo Lin, Vinicius Livramento and David Z. Pan, "Concurrent Pin Access Optimization for Unidirectional Routing", ACM/IEEE Design Automation Conference (DAC), Austin, TX, Jun 18-22, 2017.
- [C9] Jiaojiao Ou, Bei Yu, Xiaoqing Xu, Joydeep Mitra, Yibo Lin and David Z. Pan, "DSAR: DSA aware routing with simultaneous DSA guiding pattern and double patterning assignment", ACM International Symposium on Physical Design (ISPD), Portland, OR, Mar 19-22, 2017.
- [C8] Yibo Lin, Bei Yu, Xiaoqing Xu, Jhih-Rong Gao, Natarajan Viswanathan, Wen-Hao Liu, Zhuo Li, Charles J Alpert and David Z. Pan, "MrDP: Multiple-row detailed placement of heterogeneous-sized cells for advanced nodes", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Austin, TX, Nov 7-10, 2016.
- [C7] Yudong Tao, Changhao Yan, Yibo Lin, Sheng-Guo Wang, David Z. Pan and Xuan Zeng, "A novel unified dummy fill insertion framework with SQP-based optimization method", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Austin, TX, Nov 7-10, 2016.
- [C6] Yibo Lin, Bei Yu and David Z. Pan, "Detailed placement in advanced technology nodes: a survey", IEEE International Conference on Solid-State and Integrated Circuit Technology (ICSICT), Hangzhou, China, Oct 25-28, 2016. (Invited paper)
- [C5] Yibo Lin, Xiaoqing Xu, Bei Yu, Ross Baldick and David Z. Pan, "Triple/quadruple patterning layout decomposition via novel linear programming and iterative rounding", Proceedings of SPIE, San Jose, CA, Feb 21-25, 2016. (Best Student Paper Award)
- [C4] Yibo Lin, Bei Yu, Yi Zou, Zhuo Li, Charles J Alpert and David Z. Pan, "Stitch aware detailed placement for multiple e-beam lithography", IEEE/ACM Asia and South Pacific Design Automation Conference (ASPDAC), Macau, China, Jan 25-28, 2016.
- [C3] Yibo Lin, Bei Yu, Biying Xu and David Z. Pan, "Triple patterning aware detailed placement toward zero cross-row middle-of-line conflict", IEEE/ACM International Conference on Computer-Aided Design (ICCAD), Austin, TX, Nov 2-6, 2015.
- [C2] Yibo Lin, Bei Yu and David Z. Pan, "High performance dummy fill insertion with coupling and uniformity constraints", ACM/IEEE Design Automation Conference (DAC), San Francisco, CA, Jun 7-11, 2015.
- [C1] David Z. Pan, Lars Liebmann, Bei Yu, Xiaoqing Xu and Yibo Lin, "Pushing multiple patterning in sub-10nm: are we ready?", ACM/IEEE Design Automation Conference (DAC), San Francisco, CA, Jun 7-11, 2015. (Invited Paper)

# RELATED COURSES

• EE382M: VLSI I	Prof. Michael Orshansky
• EE382N: Computer Architecture	Prof. Aater Suleman
• EE382V: Optimization Issues in VLSI CAD	Prof. David Pan
• EE382M: VLSI II	Prof. Jacob Abraham
• EE380L: Engineer Programming Languages	Prof. Craig Chase
• EE382V: Nanometer Scale IC Design	Prof. Michael Orshansky
• EE382V: VLSI Physical Design Automation	Prof. David Pan
• EE381V: Advanced Algorithms	Prof. Evdokia Nikolova
• EE382V: Advanced Programming Tools	Prof. Aziz Adnan
• EE380N: Optimization in Engineering Systems	Prof. Ross Baldick
• CS383C: Numerical Analysis: Linear Algebra	Prof. Robert van de Geijn

# **SKILLS**

# Programming Languages C/C++, Python, Verilog

# Web Development

HTML5, JavaScript/jQuery

# **EDA Tools**

Cadence Virtuoso, Synopsys Design Compiler, Synopsys IC Compiler

# AWARDS AND HONORS

DAC	2019
Integration, the VLSI Journal	2018
University of Texas at Austin	2017
SPIE	2016
DAC	2014
Shanghai Jiao Tong University	2012
Shanghai Jiao Tong University	2011
Shanghai Jiao Tong University	2010
	Integration, the VLSI Journal University of Texas at Austin SPIE DAC Shanghai Jiao Tong University Shanghai Jiao Tong University